

2812

A circular black ink stamp from the Office of Intellectual Property (OIP). The text "OIP" is at the top, "JUN 22 2005" is in the center, and "PATENT & TRADEMARK OFFICE" is at the bottom. The stamp is slightly tilted.

re Application of:

Examiner: S. Isaac

Group Art Unit: 2812

$$\begin{pmatrix} \vdots \\ \vdots \end{pmatrix}$$

Date: June 21, 2005

Mail Stop Amendment
Commissioner for Patents
P.O. Box 1450
Alexandria, VA 22313-1450

INFORMATION DISCLOSURE STATEMENT

Sir:

In compliance with the duty of disclosure under 37 C.F.R. § 1.56 and in accordance with the practice under 37 C.F.R. §§ 1.97 and 1.98, the Examiner's attention is directed to the documents listed on the enclosed Form PTO-1449. Copies of the listed documents are also enclosed.

The listed documents were cited in a Search Report which issued in an European patent application corresponding to the subject application. A copy of the European Search Report, which is dated May 24, 2005, is enclosed.

The Sasaki article includes an English-language abstract.

STATEMENT UNDER 37 C.F.R. § 1.97(e)

Each item of information in this Information Disclosure Statement was first cited in any communication from a foreign Patent Office in a counterpart foreign application not more than three months prior to the filing date of this Statement.

FORMAL MATTERS

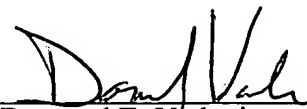
No fee is believed due; however, any fee required in connection with this paper should be charged to Deposit Account No. 06-1205.

CONCLUSION

It is respectfully requested that the above information be considered by the Examiner and that a copy of the enclosed Form PTO-1449 be returned indicating that such information has been considered.

Applicant's undersigned attorney may be reached in our Costa Mesa, California office by telephone at (714) 540-8700. All correspondence should continue to be directed to our address given below.

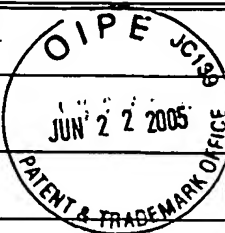
Respectfully submitted,



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New York, New York 10112-3800
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FORM PTO 1449 (modified) U.S. DEPARTMENT OF COMMERCE PATENT AND TRADEMARK OFFICE LIST OF REFERENCES CITED BY APPLICANT(S) (Use several sheets if necessary)				ATTY DOCKET NO. 00862.022541.		APPLICATION NO. 10/091,461	
				APPLICANT MASATAKA ITO			
				FILING DATE March 7, 2002		GROUP 2812	



U.S. PATENT DOCUMENTS							
EXAMINER INITIAL	DOCUMENT NUMBER	DATE	NAME	CLASS	SUBCLASS	FILING DATE IF APPROPRIATE	

FOREIGN PATENT DOCUMENTS							
DOCUMENT NUMBER	DATE	COUNTRY	CLASS	SUBCLASS	TRANSLATION YES/NO/ OR ABSTRACT		
0 926 707	06/30/1999	EP					
0 926 718	06/30/1999	EP					
0 817 248	01/07/1998	EP					

OTHER DOCUMENT(S) (Including Author, Title, Date, Pertinent Pages, Etc.)	
	H. Aga, et al., "Study of HF Defects in Thin, Bonded Silicon-on-Insulator Dependent on Original Wafers", Jpn. J. Appl. Phys., Vol. 38, May 1999, pp. 2694-2698.
	G. Sasaki, et al., "Microstructure Around Indentation of Chemical Vapor Deposition (CVD)-SiC Observed by Transmission Electron Microscopy", Yogyo-Kyokai-Shi Japan, Vol. 94, No. 8, 1986, pp. 779-783.

EXAMINER	DATE CONSIDERED
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*EXAMINER: Initial if reference considered, whether or not citation is in conformance with MPEP 609; Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.

Sheet 1 of 1